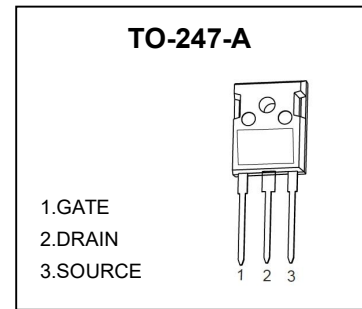


**TO-247-A Plastic-Encapsulate MOSFET**

**CJWT021SN20MK** N-Channel Power MOSFET

**Key Performance Parameters**

<b>V<sub>BR(DSS)</sub></b>	<b>R<sub>DS(on)</sub>TYP</b>	<b>I<sub>D</sub></b>
<b>200V</b>	<b>17mΩ@10V</b>	<b>85A</b>



**DESCRIPTION**

The N-Channel enhancement mode power field effect transistors is using SGT technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

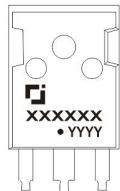
**FEATURES**

- 100% Avalanche tested
- Low drain-source on-resistance
- Low gate charge
- High current capability

**APPLICATIONS**

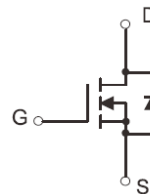
- DC/DC
- Switching application

**MARKING**



XXXXXX = 021SN20MK  
 Solid dot = Green molding compound device.  
 YYYY = Code.

**EQUIVALENT CIRCUIT**



**ABSOLUTE MAXIMUM RATINGS ( T<sub>J</sub>=25°C unless otherwise specified )**

Parameter		Symbol	Value	Unit
Drain-Source Voltage		V <sub>DS</sub>	200	V
Gate-Source Voltage		V <sub>GS</sub>	±20	V
Continuous Drain Current	T <sub>C</sub> = 25°C	I <sub>D</sub>	85	A
	T <sub>C</sub> = 100°C		54	
Pulsed Drain Current		I <sub>DM</sub> <sup>①②</sup>	340	A
Continuous Drain Current	T <sub>A</sub> = 25°C	I <sub>D</sub>	7.5	A
	T <sub>A</sub> = 75°C		5.9	
Avalanche Current		I <sub>AS</sub> <sup>③</sup>	26	A
Single Pulsed Avalanche Energy		E <sub>AS</sub> <sup>③</sup>	169	mJ
Power Dissipation		P <sub>D</sub> <sup>①</sup>	357	W
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	-55~+150	°C

**Thermal Characteristics**

Parameter	Symbol	Value		Unit
		Typ	Max	
Thermal Resistance from Junction to Case	R <sub>θJC</sub>	0.23	0.35	°C/W
Thermal Resistance from Junction to Ambient	R <sub>θJA</sub> <sup>④</sup>	30	45	°C/W

# Typical Characteristics

## ELECTRICAL CHARACTERISTICS ( $T_J=25^\circ\text{C}$ unless otherwise specified)

### Static Characteristics

Parameter	Symbol	Test Condition	Value			Unit	
			Min	Typ	Max		
Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=0V, I_D=250\mu A$	200	-	-	V	
Zero gate voltage drain current	$I_{DSS}$	$V_{DS}=200V, V_{GS}=0V$	$T_J=25^\circ\text{C}$	-	-	1.0	$\mu A$
			$T_J=125^\circ\text{C}$	-	-	100	
Gate-body leakage current	$I_{GSS}$	$V_{GS}=\pm 20V, V_{DS}=0V$	-	-	$\pm 100$	nA	
Gate-threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	2.0	3.0	4.0	V	
Static drain-source on-state resistance	$R_{DS(on)}^{(4)}$	$V_{GS}=10V, I_D=20A$	$T_J=25^\circ\text{C}$	-	17	21	m $\Omega$
			$T_J=125^\circ\text{C}$	-	34	43	
Forward transconductance	$g_{FS}$	$V_{DS}=5V, I_D=20A$	-	45	-	S	

### Dynamic Characteristics<sup>(5)</sup>

Input capacitance	$C_{iss}$	$V_{GS}=0V, V_{DS}=100V,$ $f=1\text{MHz}$	-	2677	-	$\mu F$
Output capacitance	$C_{oss}$		-	217	-	
Reverse transfer capacitance	$C_{rss}$		-	8	-	
Gate resistance	$R_g$	$f=1\text{MHz}$	-	4.6	-	$\Omega$
Total gate charge	$Q_g$	$V_{GS}=10V, V_{DS}=100V, I_D=20A$	-	34.4	-	nC
Gate charge at threshold	$Q_{G(th)}$		-	7.5	-	
Gate-source charge	$Q_{gs}$		-	11.4	-	
Gate-drain charge	$Q_{gd}$		-	5.4	-	
Turn-on delay time	$t_{d(on)}$	$V_{DD}=100V, V_{GS}=10V,$ $I_D=20A, R_g=10\Omega$	-	28	-	ns
Turn-on rise time	$t_r$		-	28	-	
Turn-off delay time	$t_{d(off)}$		-	58	-	
Turn-off fall time	$t_f$		-	46	-	

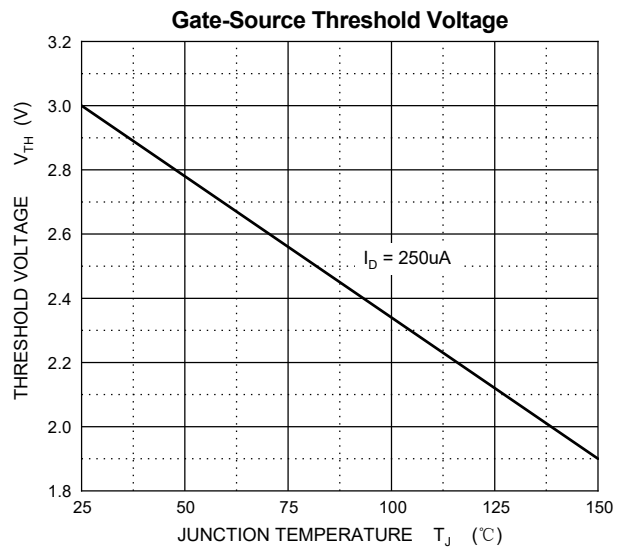
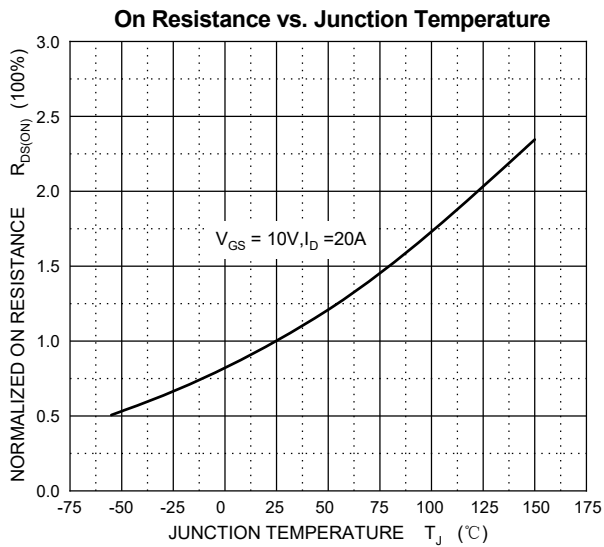
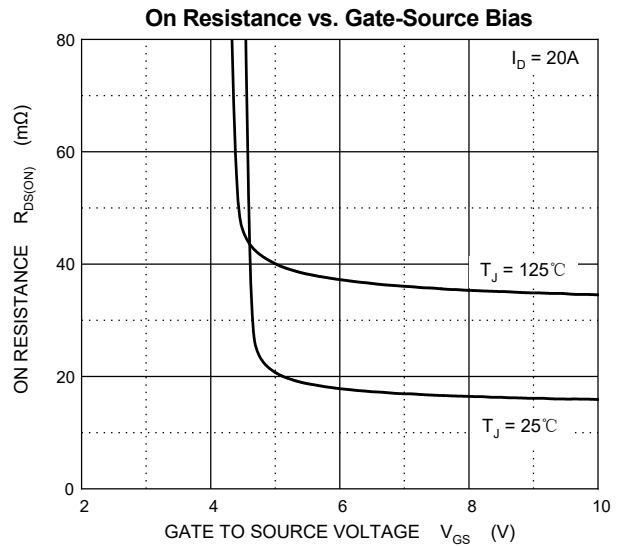
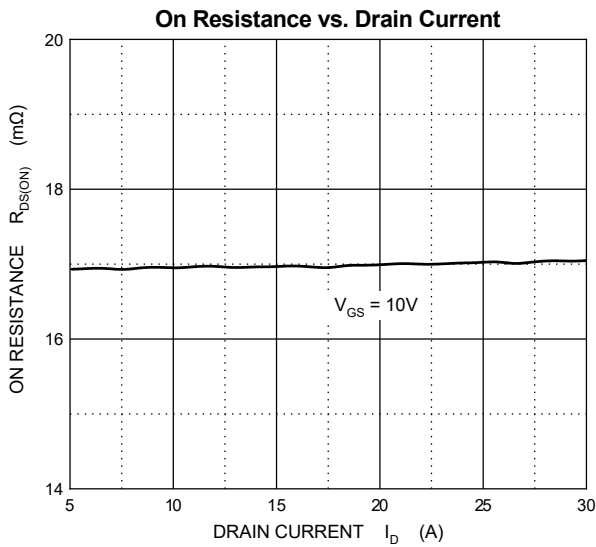
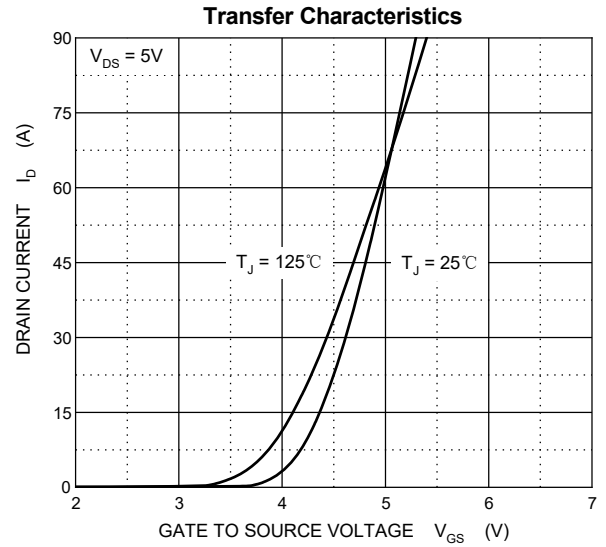
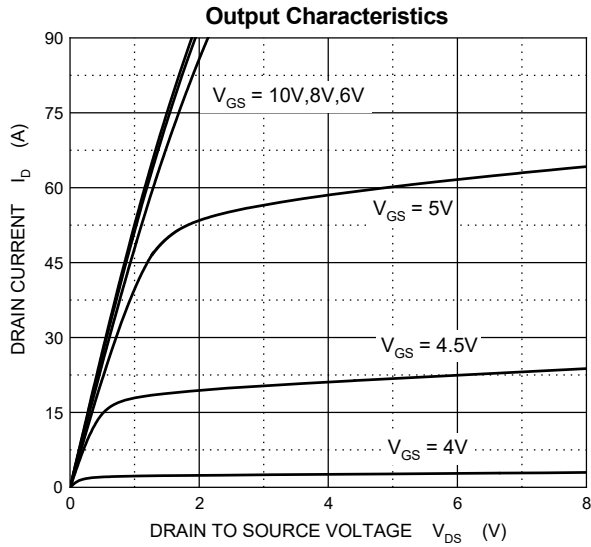
### Reverse Diode Characteristics

Drain-source diode forward voltage	$V_{SD}^{(4)}$	$V_{GS}=0V, I_S=20A$	-	-	1.2	V
Continuous drain-source diode forward current	$I_S^{(1)}$		-	-	85	A
Pulsed drain-source diode forward current	$I_{SM}^{(1)(2)}$		-	-	340	A
Reverse recovery time	$t_{rr}$	$V_{DD}=100V, I_S=20A,$	-	119	-	ns
Reverse recovery charge	$Q_{rr}$	$di/dt=100A/\mu s$	-	493	-	nC

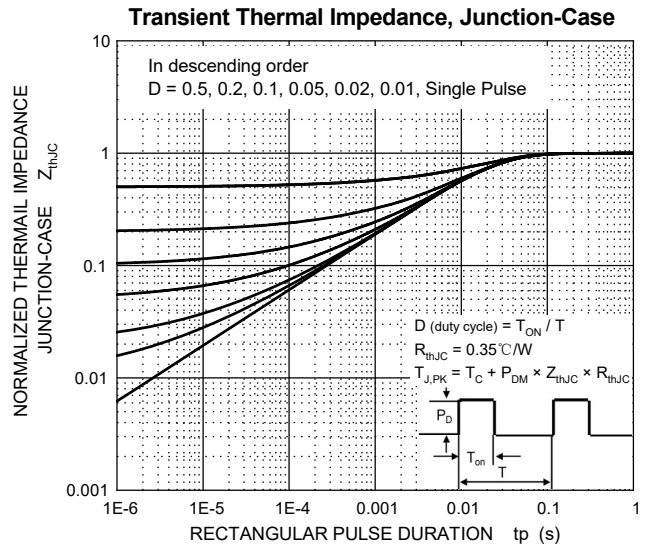
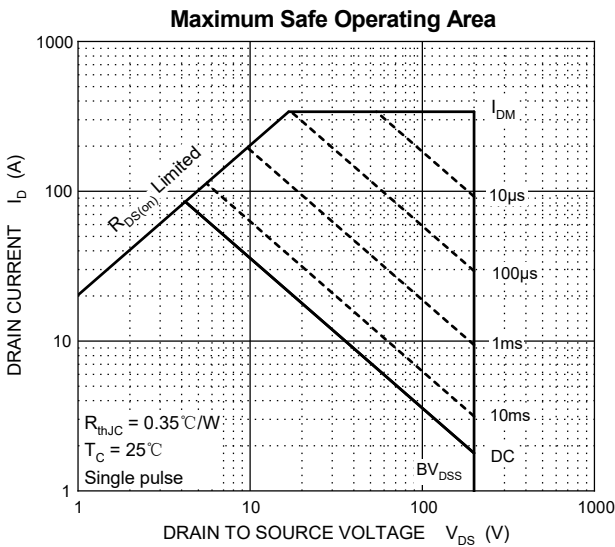
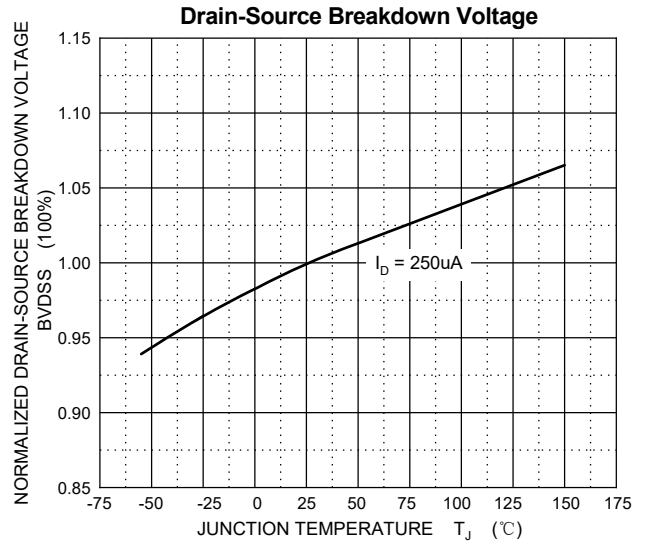
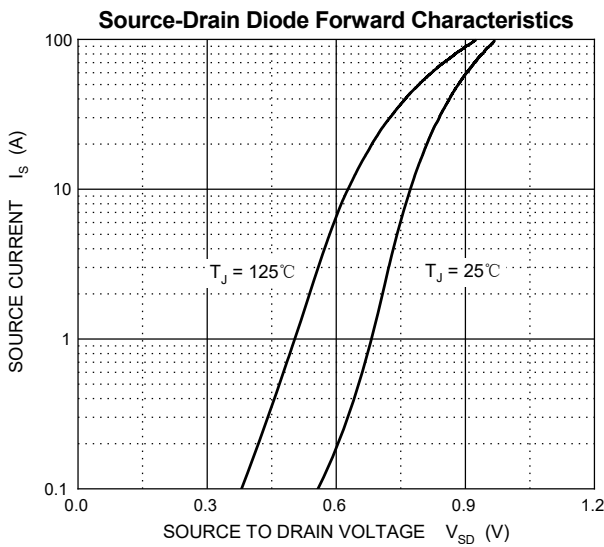
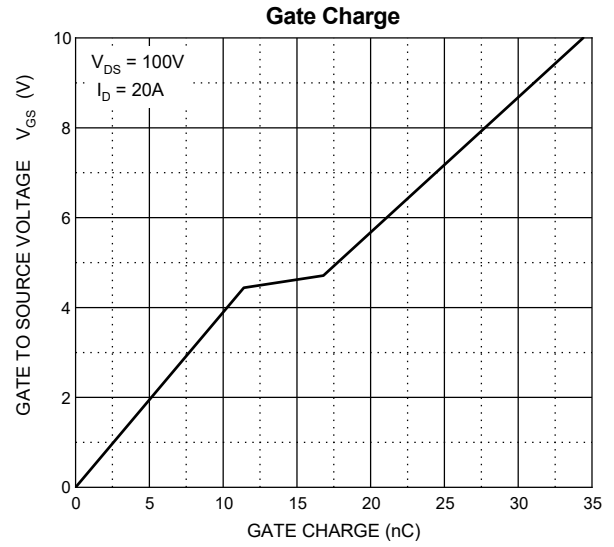
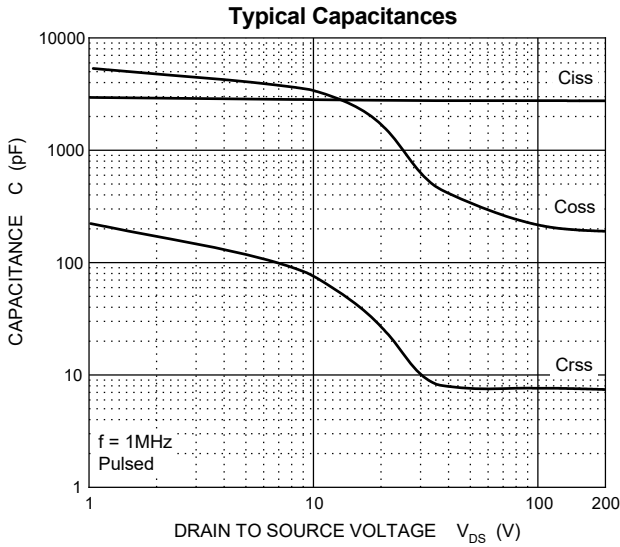
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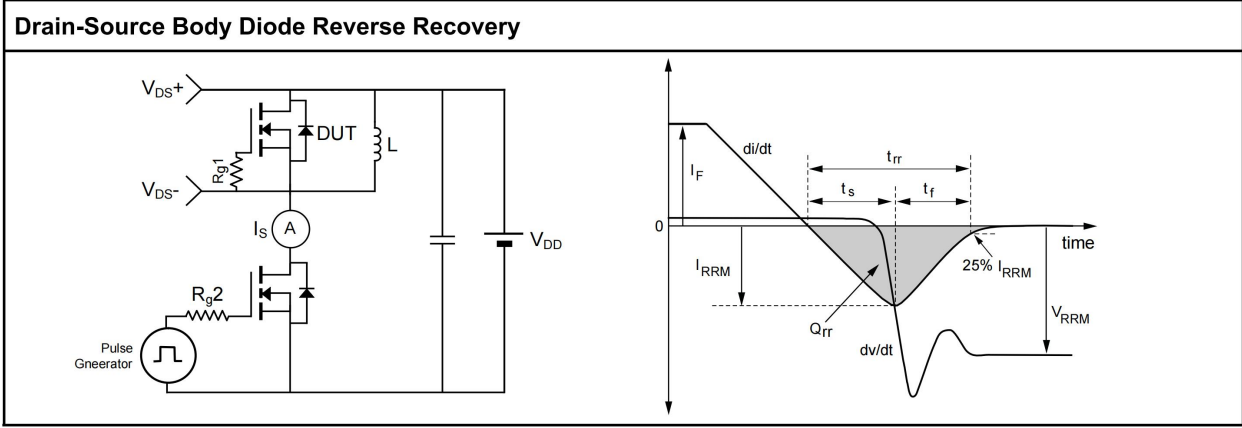
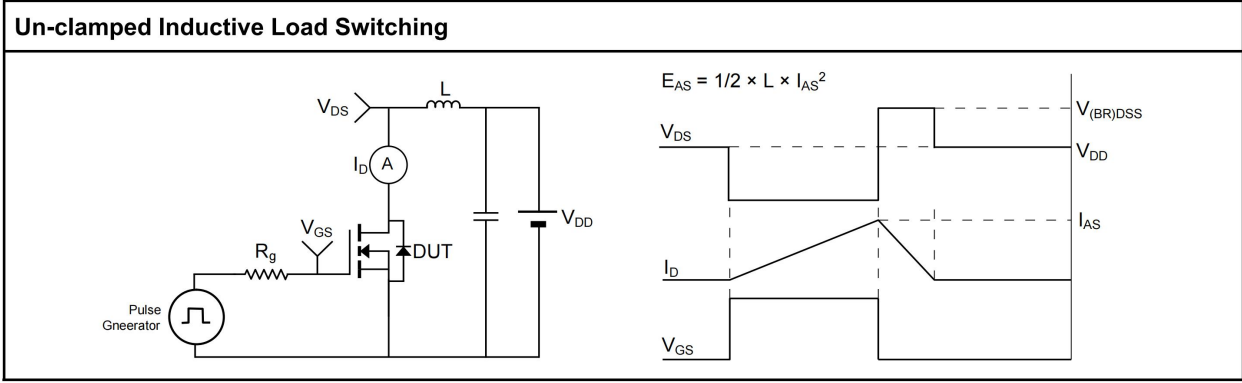
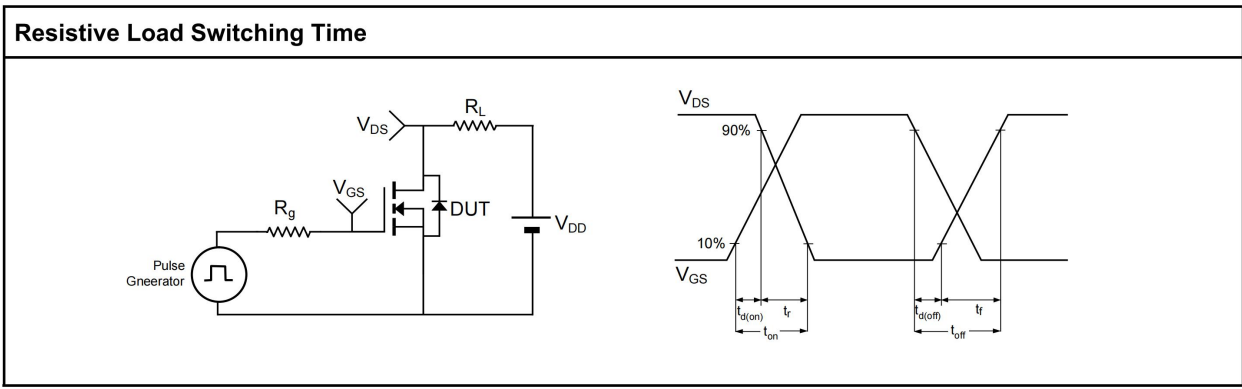
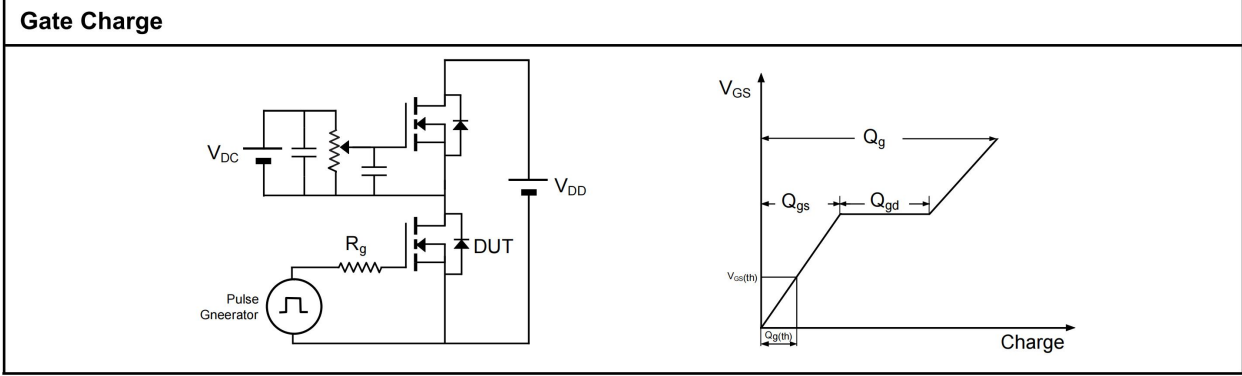
- ①.  $T_C=25^\circ\text{C}$  Limited only by maximum temperature allowed.
- ②.  $P_W \leq 10\mu s$ , Duty cycle  $\leq 1\%$ .
- ③. EAS condition:  $V_{DD}=100V, V_{GS}=10V, L=0.5\text{mH}, R_g=25\Omega$  Starting  $T_J=25^\circ\text{C}$ .
- ④. Pulse Test : Pulse Width  $\leq 380\mu s$ , duty cycle  $\leq 2\%$ .
- ⑤. Guaranteed by design, not subject to production.
- ⑥. Device mounted in a still air environment with  $T_A=25^\circ\text{C}$ .

# Typical Characteristics

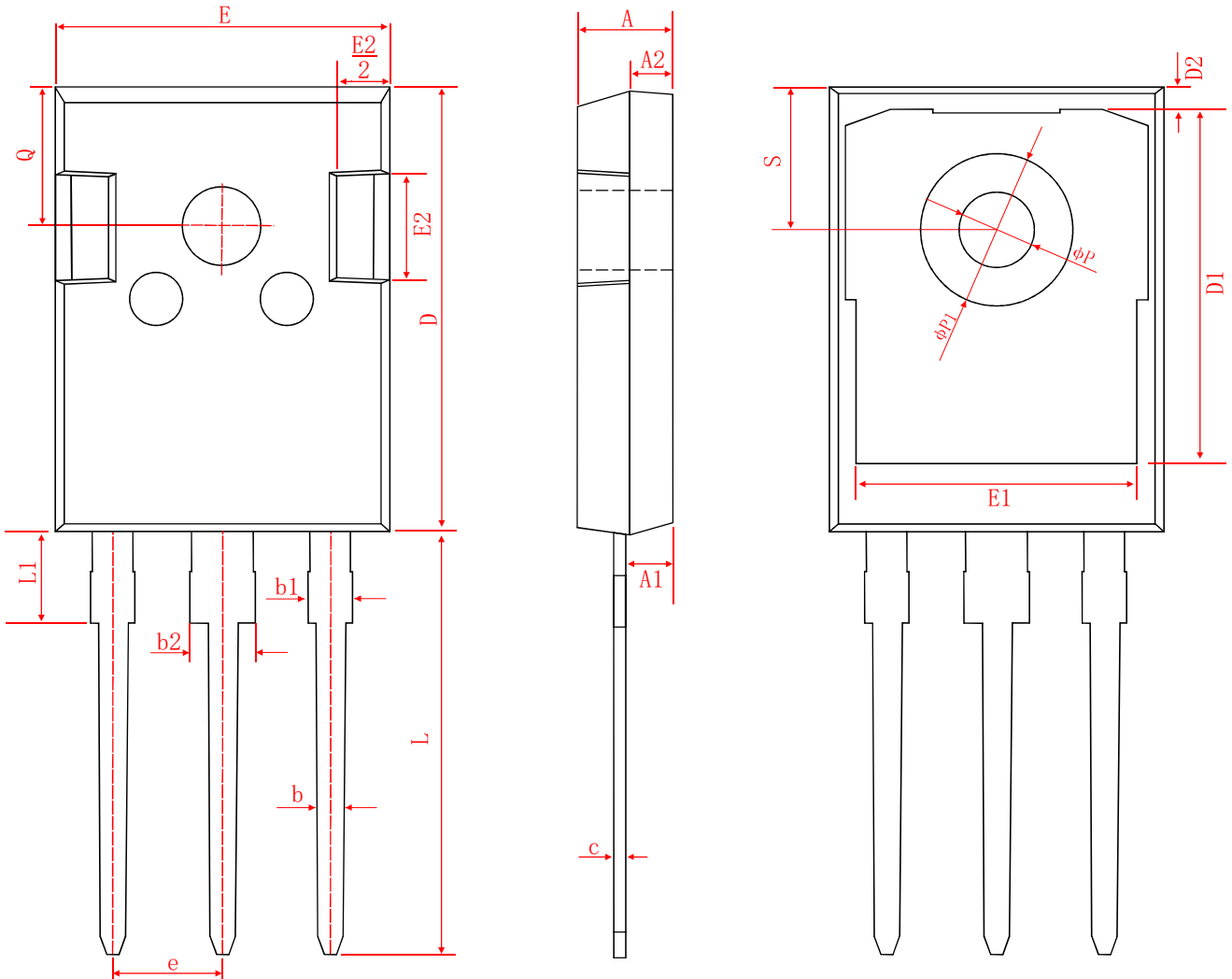


# Typical Characteristics





# TO-247-A Package Outline Dimensions



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	4.90	5.10	0.193	0.201
A1	2.31	2.51	0.091	0.099
A2	1.90	2.10	0.075	0.083
b	1.15	1.25	0.045	0.049
b1	1.95	2.25	0.077	0.089
b2	2.95	3.25	0.116	0.128
c	0.55	0.65	0.022	0.026
D	20.90	21.10	0.823	0.831
D1	16.35	16.75	0.644	0.659
D2	1.05	1.35	0.041	0.053
e	5.44 TYP.		0.214 TYP.	
E	15.70	15.90	0.618	0.626
E1	13.10	13.40	0.516	0.528
E2	4.90	5.10	0.193	0.201
Q	5.60	6.00	0.220	0.236
S	6.05	6.25	0.238	0.246
L	19.80	20.15	0.780	0.793
L1		4.30		0.169
ΦP	3.45	3.65	0.136	0.144
ΦP1	7.03	7.33	0.277	0.289